

 Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination	
10/772,879	AMEMIYA, SHINICHI		
Examiner	Art Unit		
Michael Rozanski	3768		

SEARCHED				
Class	Subclass	Date	Examiner	
600	437	9/22/2006	M.R.	
600	459	9/22/2006	M.R.	
307	112	9/22/2006	M.R.	
367	138	9/22/2006	M.R.	
377	58	9/22/2006	M.R.	
600	443	9/22/2006	M.R.	
73	626	9/22/2006	M.R.	
600	447	9/22/2006	M.R.	
323	234	9/22/2006	M.R.	
600	446	9/22/2006	M.R.	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
PG-PUB search		11/7/2007	MR		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Performed EAST search	9/22/2006	M.R.		
Inventor name search	9/22/2006	M.R.		
STIC Plus search	9/27/2006	M.R.		
Consulted primary examiner Jaworski	9/28/2006	M.R.		
Updated EAST search	6/13/2007	M.R.		
Updated EAST search	10/16/2007	MR		
Consulted primary examiner Winakur	11/7/2007	MR		
Consulted primary examiner Jaworski	11/7/2007	MR		